

• High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s,

- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

FEATURES

· Isolated Package

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. The isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFI820GPbF
	SiHFI820G-E3
SnPb	IRFI820G
	SiHFI820G

Power MOSFET

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	500	V	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current	V_{GS} at 10 V $\frac{T}{T_0}$	T _C = 25 °C	1-	2.1		
		T _C = 100 °C	ID	1.3	А	
Pulsed Drain Current ^a			I _{DM}	8.4	1	
Linear Derating Factor				0.24	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	110	mJ	
Repetitive Avalanche Current ^a			I _{AR} 2.1		A	
Repetitive Avalanche Energy ^a			E _{AR}	3.0	mJ	
Maximum Power Dissipation	T _C =	25 °C	PD	30	W	
Peak Diode Recovery dV/dt ^c			dV/dt	3.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. V_{DD} = 50 V, starting T_J = 25 °C, L = 44 mH, R_G = 25 $\Omega,$ I_{AS} = 2.1 A (see fig. 12).

c. $I_{SD} \leq 2.1$ A, $dI/dt \leq 50$ A/µs, $V_{DD} \leq V_{DS}, \, T_J \leq 150 \ ^{\circ}C.$

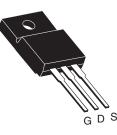
d. 1.6 mm from case.

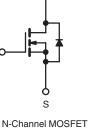
* Pb containing terminations are not RoHS compliant, exemptions may apply



$\begin{tabular}{|c|c|c|c|c|} \hline PRODUCT SUMMARY \\ \hline V_{DS}(V) & 500 \\ \hline R_{DS(on)}(\Omega) & V_{GS} = 10 \ V & 3.0 \\ \hline Q_g (Max.) (nC) & 24 \\ \hline Q_{gs} (nC) & 3.3 \\ \hline Q_{gd} (nC) & 13 \\ \hline Configuration & Single \\ \hline \end{tabular}$

TO-220 FULLPAK





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PARAMETER	SYMBOL	TYP.		MAX.	MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-		65		0044			
Maximum Junction-to-Case (Drain)	R _{thJC}	-	4.1			°C/W			
SPECIFICATIONS $T_J = 25 \degree C$, t	unless otherv	vise noted					•	•	
PARAMETER	SYMBOL	TEST	CONDITION	IS	MIN.	TYP.	MAX.	UNI	
Static									
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$) V, I _D = 250	μA	500	-	-	v	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	to 25 °C, I _D :	= 1 mA	-	0.59	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$			2.0	-	4.0	V	
Gate-Source Leakage	I _{GSS}	VG	V _{GS} = ± 20 V			-	± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 5	V _{DS} = 500 V, V _{GS} = 0 V		-	-	25		
		V _{DS} = 400 V, V	$V_{DS} = 400 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125 \text{ °C}$			-	250	μA	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	1	1.3 A ^b	-	-	3.0	Ω	
Forward Transconductance	g _{fs}	V _{DS} = 5	50 V, I _D = 1.3	Ab	1.5	-	-	S	
Dynamic							I		
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5 f = 1.0 MHz		-	360	-	- pF		
Output Capacitance	C _{oss}			-	92	-			
Reverse Transfer Capacitance	C _{rss}			-	37	-			
Drain to Sink Capacitance	C			-	12	-			
Total Gate Charge	Qg				-	-	24		
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{CS} = 10 \text{ V}$ $I_D = 2.1 \text{ A}, V_{DS} = 40$		-	-	3.3	nC	
Gate-Drain Charge	Q _{gd}	see fig. 6		6 and 135			13	-	
Turn-On Delay Time	t _{d(on)}				-	8.0	-		
Rise Time	t _r	V_{DD} = 250 V, I_D = 2.1 A , R_G = 18 $\Omega,~R_D$ = 120 $\Omega,~see~fig.~10^{b}$		_	8.6	-	- ns		
Turn-Off Delay Time	t _{d(off)}			_	33	-			
Fall Time	t _f			_	16	<u> </u>			
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	- nH		
Internal Source Inductance	L _S			-	7.5	-			
Drain-Source Body Diode Characteristic	s						•		
Continuous Source-Drain Diode Current	١ _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.1	A		
Pulsed Diode Forward Current ^a	I _{SM}			-	-	8.0			
Body Diode Voltage	V_{SD}	$T_{J} = 25 \ ^{\circ}C, \ I_{S} = 2.1 \ A, \ V_{GS} = 0 \ V^{b}$		-	-	1.6	V		
Body Diode Reverse Recovery Time	t _{rr}	$T_{J} = 25 \text{ °C}, I_{F} = 2.1 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^{b}$		-	260	520	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.70	1.4	μC		
Forward Turn-On Time	t _{on}	Intrinsic turn	on time is n	ealiaible (turn	on is dor	ninated b	v Ls and	(م ا	

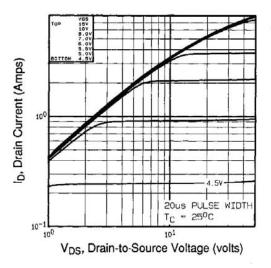
Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Fig. 1 - Typical Output Characteristics, $T_C = 25 \ ^{\circ}C$

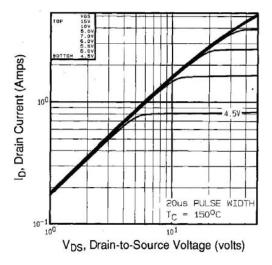


Fig. 2 - Typical Output Characteristics, T_C = 150 $^\circ C$

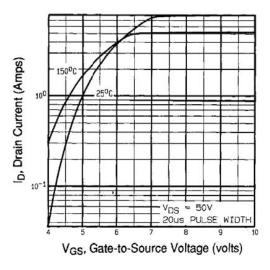


Fig. 3 - Typical Transfer Characteristics

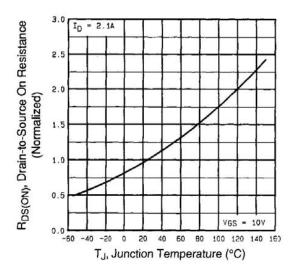


Fig. 4 - Normalized On-Resistance vs. Temperature

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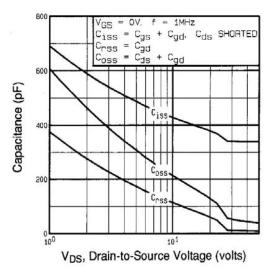


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

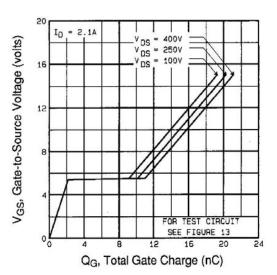


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

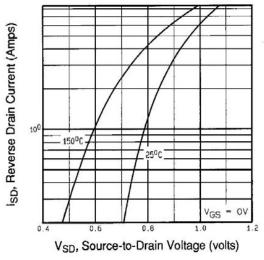
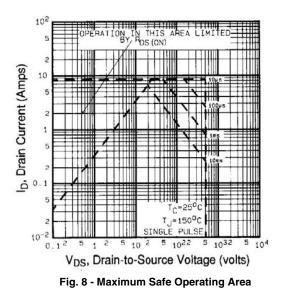


Fig. 7 - Typical Source-Drain Diode Forward Voltage





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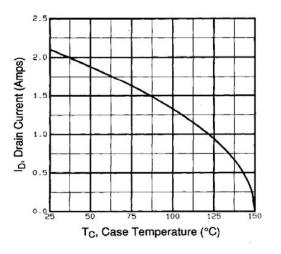


Fig. 9 - Maximum Drain Current vs. Case Temperature

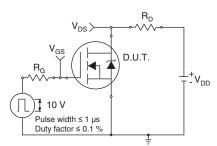


Fig. 10a - Switching Time Test Circuit

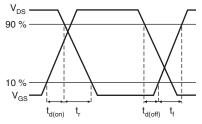
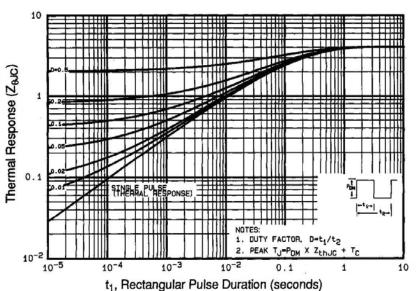
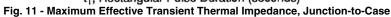


Fig. 10b - Switching Time Waveforms





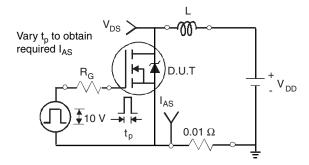


Fig. 12a - Unclamped Inductive Test Circuit

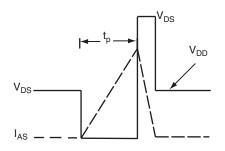
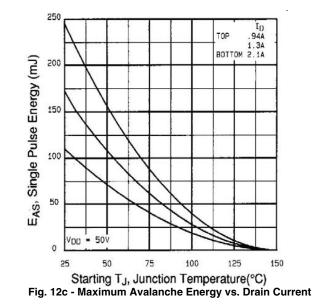


Fig. 12b - Unclamped Inductive Waveforms

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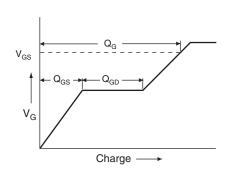
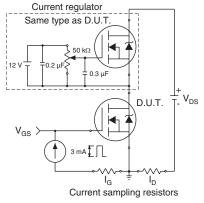


Fig. 13a - Basic Gate Charge Waveform

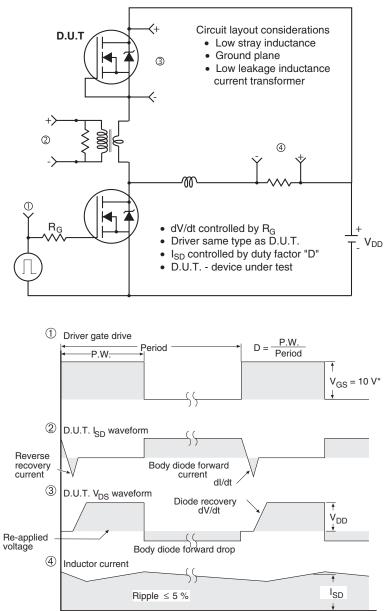






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Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?91158.



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